

Search Notes

Application/Control No.

10/562,169

Examiner

Phu K. Nguyen

Applicant(s)/Patent under
Reexamination

JOHNSON ET AL.

Art Unit

2628

SEARCHED

Class	Subclass	Date	Examiner
345	107	2/19/2007	PN
	82	2/19/2007	PN
427	213.3	2/19/2007	PN
204	606	2/19/2007	PN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
WEST search - optical state, gray scale, calibration, look up table.	2/19/2007	PN
Nonpatent Literature IEEE, ACM search - optical state, gray scale, calibration, look up table.	2/19/2007	PN
Inventor Name search	2/19/2007	PN